## Application/Control No. Applicant(s)/Patent Under Reexamination 10/726,675 HIRANO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Nguyen T. Ha 2831 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-6,433,417 08-2002 Aoyama, Makoto Α 257/696 US-В US-С US-D Ε US-US-F US-G Н US-US-J US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code MM-YYYY Name Classification Ν 0 Р Q R

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